

CNY171, CNY172, CNY173, CNY174, CNY17F1, CNY17F2, CNY17F3, CNY17F4, MOC8101, MOC8102, MOC8103, MOC8104, MOC8105, MOC8106, MOC8107, MOC8108 Phototransistor Optocouplers

Features

- CNY171/2/3/4 and CNY17F1/2/3/4 are also available in white package by specifying M suffix (eg. CNY17F2M)
- UL recognized (File # E90700)
- VDE recognized
 - Add option V for white package (e.g., CNY17F2VM)
 - File #102497
 - Add option '300' for black package (e.g., CNY17F2300)
 - File #94766
- Current transfer ratio in select groups
- High BV_{CEO} —70V minimum (CNY17X/M, CNY17FX/M, MOC8106/7/8)
- Closely matched current transfer ratio (CTR) minimizes unit-to-unit variation.
- Very low coupled capacitance along with no chip to pin 6 base connection for minimum noise susceptibility (CNY17FX/M, MOC810X)

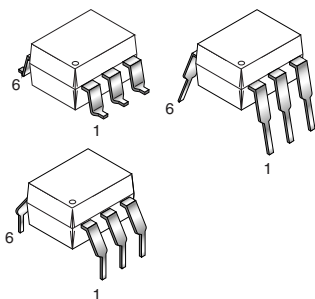
Applications

- Power supply regulators
- Digital logic inputs
- Microprocessor inputs
- Appliance sensor systems
- Industrial controls

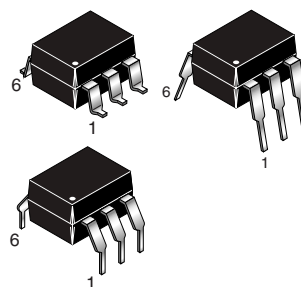
Description

The CNY17, CNY17F and MOC810X devices consist of a Gallium Arsenide IRED coupled with an NPN phototransistor in a dual in-line package.

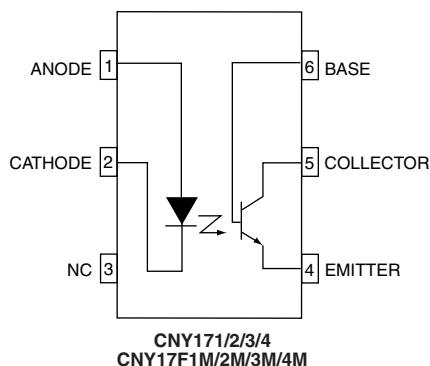
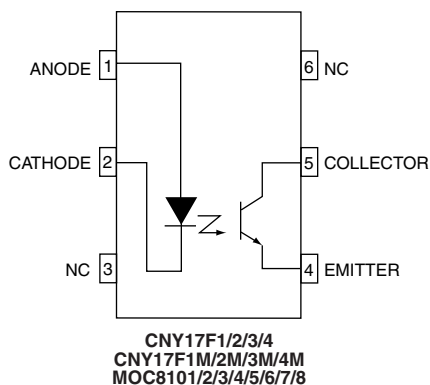
White Package (-M Suffix)



Black Package (No -M Suffix)



Schematic



Absolute Maximum Ratings

Parameters	Symbol	Device	Value	Units
TOTAL DEVICE				
Storage Temperature	T _{STG}	M	-40 to +150	°C
		non M	-55 to +150	
Operating Temperature	T _{OPR}	M	-40 to +100	°C
		non M	-55 to +100	
Lead Solder Temperature	T _{SOL}	All	260 for 10 sec	°C
Total Device Power Dissipation @ 25°C (LED plus detector)	P _D	M	250	mW
Derate Linearly From 25°C		non M	250	
		M	2.94	mW/°C
		non M	3.30	
EMITTER				
Continuous Forward Current	I _F	M	60	mA
		non M	100	
Reverse Voltage	V _R	All	6	V
Forward Current - Peak (1 μs pulse, 300 pps)	I _F (pk)	M	1.5	A
		non M	1.0	
LED Power Dissipation 25°C Ambient	P _D	M	120	mW
		non M	150	
		M	1.41	mW/°C
		non M	1.8	
DETECTOR				
Continuous Collector Current	I _C	All	50	mA
Collector-Emitter Voltage	V _{CEO}	CNY17X/M, CNY17FX/M, MOC8106/7/8	70	V
		MOC8101/2/3/4/5	30	V
Emitter Collector Voltage	V _{ECO}	All	7	V
Detector Power Dissipation @ 25°C	P _D	M	150	mW
Derate Linearly from 25°C		non M	150	
		M	1.76	mW/°C
		non M	2.0	

Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless otherwise specified.)⁽¹⁾**Individual Component Characteristics**

Parameters	Test Conditions	Symbol	Device	Min	Typ	Max	Units
EMITTER							
Input Forward Voltage	$I_F = 60\text{ mA}$	V_F	CNY17FX/M CNY17X/M	1.0	1.35	1.65	V
	$I_F = 10\text{ mA}$		MOC810X	1.0	1.15	1.50	
Capacitance	$V_F = 0\text{ V}$, $f = 1.0\text{ MHz}$	C_J	All		18		pF
Reverse Leakage Current	$V_R = 6\text{ V}$	I_R	All		0.001	10	μA

Individual Component Characteristics (Continued)

Parameters	Test Conditions	Symbol	Device	Min	Typ	Max	Units
DETECTOR							
Breakdown Voltage Collector to Emitter	$I_C = 1.0 \text{ mA}, I_F = 0$	BV_{CEO}	MOC8101/2/3/4/5	30	100		V
			MOC8106/7/8 CNY17F1/2/3/4/M CNY171/2/3/4/M	70	100		
Collector to Base	$I_C = 10 \mu\text{A}, I_F = 0$	BV_{CBO}	CNY171/2/3/4/M	70	120		
Emitter to Collector	$I_E = 100 \mu\text{A}, I_F = 0$	BV_{ECO}	All	7	10		
Leakage Current Collector to Emitter	$V_{CE} = 10 \text{ V}, I_F = 0$	I_{CEO}	All		1	50	nA
Collector to Base	$V_{CB} = 10 \text{ V}, I_F = 0$	I_{CBO}	CNY171/2/3/4/M			20	nA
Capacitance Collector to Emitter	$V_{CE} = 0, f = 1 \text{ MHz}$	C_{CE}	All		8		pF
Collector to Base	$V_{CB} = 0, f = 1 \text{ MHz}$	C_{CB}	CNY171/2/3/4/M		20		pF
Emitter to Base	$V_{EB} = 0, f = 1 \text{ MHz}$	C_{EB}	CNY171/2/3/4/M		10		pF

Isolation Characteristics

Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Units
Input-Output Isolation Voltage	$f = 60 \text{ Hz}, t = 1 \text{ min. (4)}$	V_{ISO}	Black Package	5300			Vac(rms)*
	$f = 60 \text{ Hz}, t = 1 \text{ sec. (4)}$		'M' White Package	7500			Vac(pk)
Isolation Resistance	$V_{I-O} = 500 \text{ VDC (4)}$	R_{ISO}	All	10^{11}			Ω
Isolation Capacitance	$V_{I-O} = \emptyset, f = 1 \text{ MHz (4)}$	C_{ISO}	Black Package		0.5		pF
			'M' White Package		0.2		

Note

* 5300 Vac(rms) for 1 minute equates to approximately 9000 Vac (pk) for 1 second

** Typical values at $T_A = 25^\circ\text{C}$

Transfer Characteristics ($T_A = 25^\circ\text{C}$ Unless otherwise specified.)⁽¹⁾

DC Characteristics		Test Conditions	Symbol	Min	Typ	Max	Units
Coupled							
Output Collector Current	MOC8101	(I _F = 10 mA, V _{CE} = 10 V)	(CTR) ⁽²⁾	50	—	80	%
	MOC8102			73	—	117	
	MOC8103			108	—	173	
	MOC8104			160	—	256	
	MOC8105			65	—	133	
	MOC8106			50	—	150	
	MOC8107			100	—	300	
	MOC8108			250	—	600	
	CNY17F1/1M	(I _F = 10 mA, V _{CE} = 5 V)		40	—	80	
	CNY17F2/2M			63	—	125	
	CNY17F3/3M			100	—	200	
	CNY17F4/4M			160	—	320	
	CNY171/1M			40	—	80	
	CNY172/2M			63	—	125	
	CNY173/3M			100	—	200	
	CNY174/4M			160	—	320	
Collector-Emitter Saturation Voltage	CNY17XM/FXM	(I _C = 2.5 mA, I _F = 10 mA)	V _{CE(sat)}	—	—	0.4	V
	MOC8101/2/3/4/5/6/7/8	(I _C = 500 μA, I _F = 5.0 mA)					
	CNY17X/FX	(I _F = 10 mA, I _C = 2.5 mA)		—	—	0.3	

AC Characteristics ⁽³⁾		Test Conditions	Symbol	Min	Typ*	Max	Units
Non-Saturated Switching Time							
Turn-On Time	MOC8101/2/3/4/5	$(I_C = 2.0\text{ mA}, V_{CC} = 10\text{ V}, R_L = 100\text{ }\Omega)$	t_{on}	—	2	20	μs
	MOC8106/7/8					—	
	CNY17X/FX					10	
Turn-Off Time	MOC8101/2/3/4/5	$(I_C = 2.0\text{ mA}, V_{CC} = 10\text{ V}, R_L = 100\text{ }\Omega)$	t_{off}	—	3	20	μs
	MOC8106/7/8					—	
	CNY17X/FX					10	
Delay Time	CNY17XM/FXM	$(I_F = 10\text{ mA}, V_{CC} = 5\text{ V}, R_L = 75\text{ }\Omega)$	t_d	—	—	5.6	μs
Rise Time	All Devices	$(I_C = 2.0\text{ mA}, V_{CC} = 10\text{ V}, R_L = 100\text{ }\Omega)$	t_r	—	1	—	μs
	CNY17XM/FXM	$(I_F = 10\text{ mA}, V_{CC} = 5\text{ V}, R_L = 75\text{ }\Omega)$				4.0	
Storage Time	CNY17XM/FXM	$(I_F = 10\text{ mA}, V_{CC} = 5\text{ V}, R_L = 75\text{ }\Omega)$	t_s	—	—	4.1	μs
Fall Time	All Devices	$(I_C = 2.0\text{ mA}, V_{CC} = 10\text{ V}, R_L = 100\text{ }\Omega)$	t_f	—	2	—	μs
	CNY17XM/FXM	$(I_F = 10\text{ mA}, V_{CC} = 5\text{ V}, R_L = 75\text{ }\Omega)$				3.5	

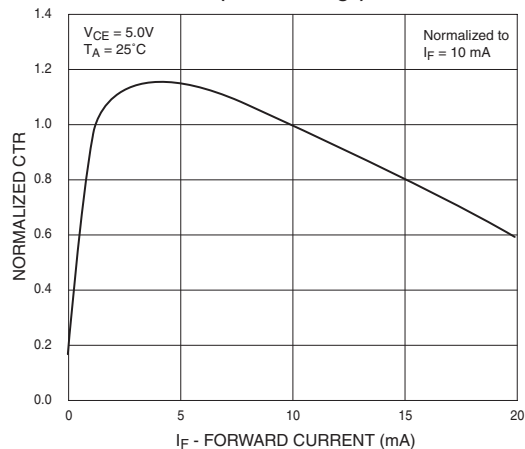
Transfer Characteristics (continued) ($T_A = 25^\circ\text{C}$ Unless otherwise specified.)⁽¹⁾

AC Characteristics ⁽³⁾		Test Conditions	Symbol	Min	Typ	Max	Units
Saturated Switching Times							
Turn-on Time	CNY171/F1	(I _F = 20 mA, V _{CE} = 0.4 V)	t _{on}	—	—	5.5	μs
	CNY172/F2	(I _F = 10 mA, V _{CE} = 0.4 V)		—	—	8.0	
	CNY173/F3						
	CNY174/F4						
Rise Time	CNY171/F1	(I _F = 20 mA, V _{CE} = 0.4 V)	t _r	—	—	4.0	μs
	CNY172/F1	(I _F = 10 mA, V _{CE} = 0.4 V)		—	—	6.0	
	CNY173/F3						
	CNY174/F4						
	CNY171M/F1M			(I _F = 20 mA, V _{CC} = 5 V, R _L = 1 KΩ)	—	—	
	CNY172M/3M/4M CNY17F2M/F3M/F4M	(I _F = 10 mA, V _{CC} = 5 V, R _L = 1 KΩ)		—	—	6.0	
Delay Time	CNY171M/F1M	(I _F = 20 mA, V _{CC} = 5 V, R _L = 1 KΩ)	t _d	—	—	5.5	μs
	CNY172M/3M/4M CNY17F2M/F3M/F4M	(I _F = 10 mA, V _{CC} = 5 V, R _L = 1 KΩ)		—	—	8.0	
Turn-off Time	CNY171/F1	(I _F = 20 mA, V _{CE} = 0.4 V)	t _{off}	—	—	34	μs
	CNY172/F2	(I _F = 10 mA, V _{CE} = 0.4 V)		—	—	39	
	CNY173/F3						
	CNY174/F4						
Fall Time	CNY171/F1	(I _F = 20 mA, V _{CE} = 0.4 V)	t _f	—	—	20	μs
	CNY172/F2	(I _F = 10 mA, V _{CE} = 0.4 V)		—	—	24	
	CNY173/F3						
	CNY174/F4						
	CNY171M/F1M			(I _F = 20 mA, V _{CC} = 5V, R _L = 1KΩ)	—	—	
	CNY172M/3M/4M CNY17F2M/F3M/F4M	(I _F = 10 mA, V _{CC} = 5V, R _L = 1KΩ)	—	—	24.0		
Storage Time	CNY171M/F1M	(I _F = 20 mA, V _{CC} = 5V, R _L = 1KΩ)	t _s	—	—	34.0	μs
	CNY172M/3M/4M CNY17F2M/F3M/F4M	(I _F = 10 mA, V _{CC} = 5V, R _L = 1KΩ)		—	—	39.0	

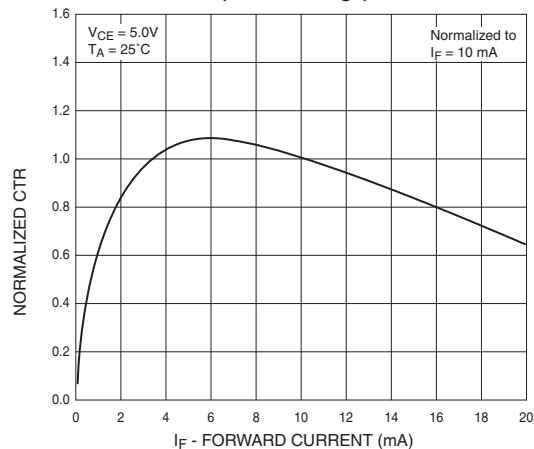
** All typicals at $T_A = 25^\circ\text{C}$ **Notes:**

1. Always design to the specified minimum/maximum electrical limits (where applicable).
2. Current Transfer Ratio (CTR) = $I_C/I_F \times 100\%$.
3. For test circuit setup and waveforms, refer to Figures 20.
4. For this test, Pins 1 and 2 are common, and Pins 4 and 5 are common.

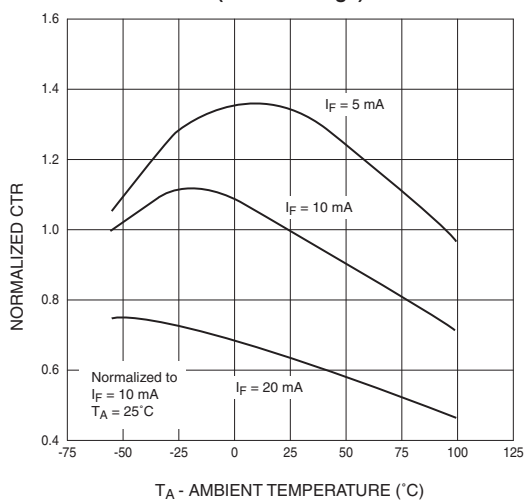
**Fig.1 Normalized CTR vs. Forward Current
(Black Package)**



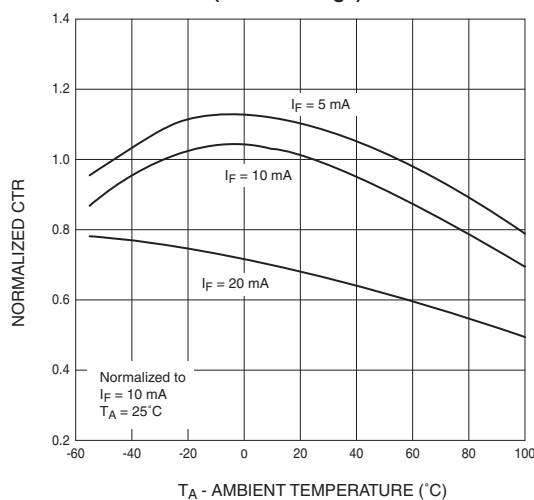
**Fig.2 Normalized CTR vs. Forward Current
(White Package)**



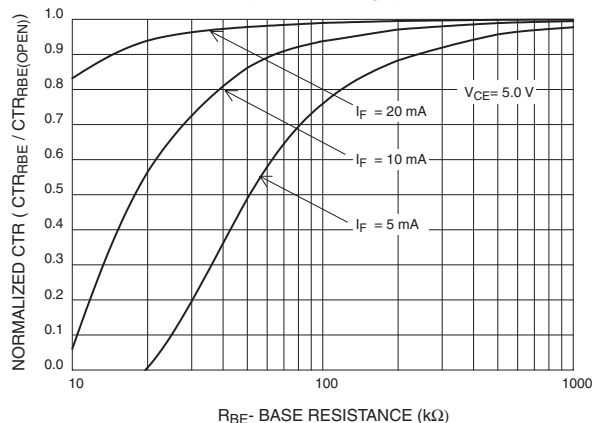
**Fig. 3 Normalized CTR vs. Ambient Temperature
(Black Package)**



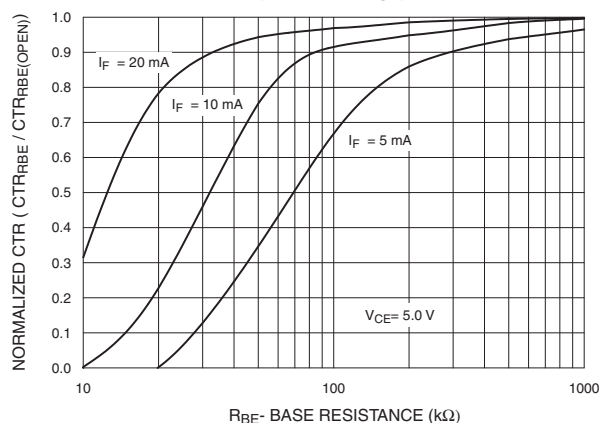
**Fig. 4 Normalized CTR vs. Ambient Temperature
(White Package)**



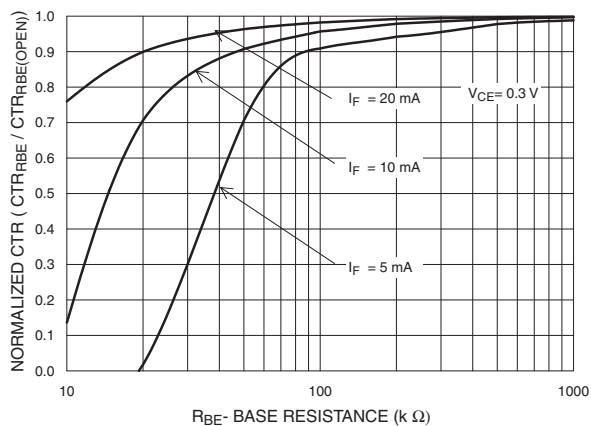
**Fig. 5 CTR vs. RBE (Unsaturated)
(Black Package)**



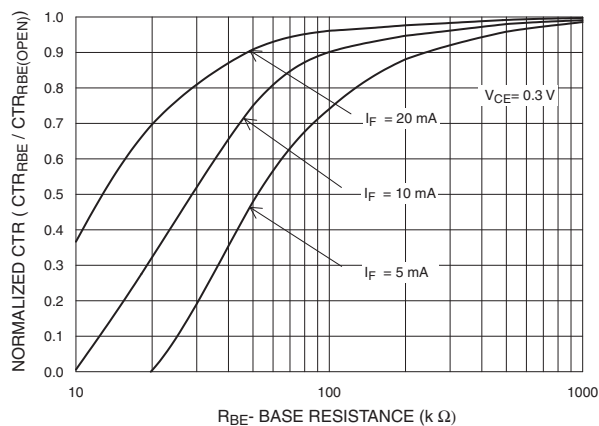
**Fig. 6 CTR vs. RBE (Unsaturated)
(White Package)**



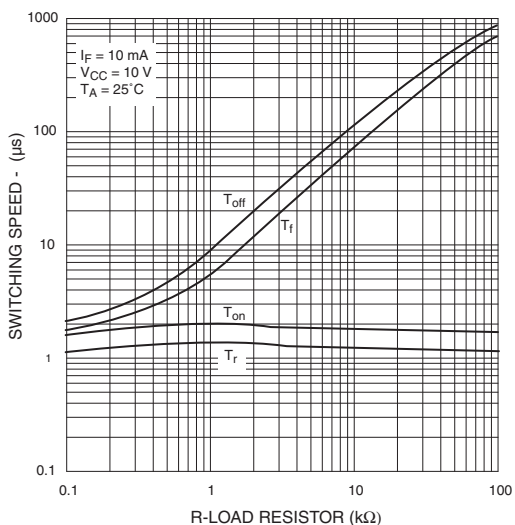
**Fig. 7 CTR vs. R_{BE} (Saturated)
(Black Package)**



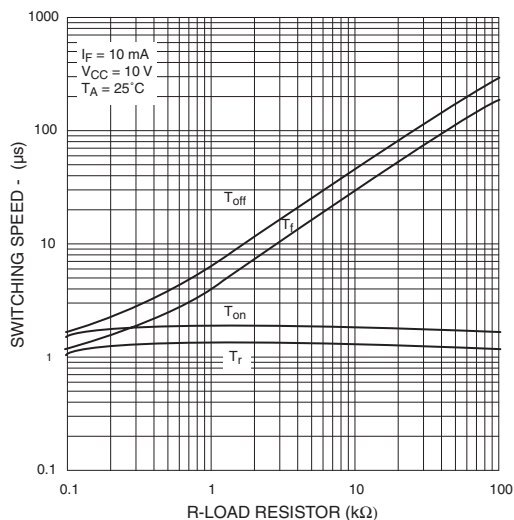
**Fig. 8 CTR vs. R_{BE} (Saturated)
(White Package)**



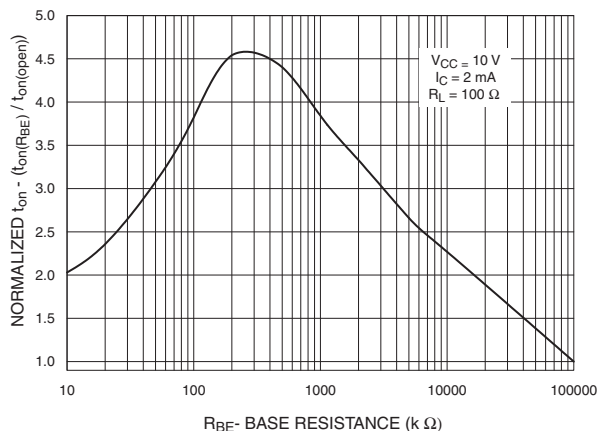
**Fig. 9 Switching Speed vs. Load Resistor
(Black Package)**



**Fig. 10 Switching Speed vs. Load Resistor
(White Package)**



**Fig. 11 Normalized t_{on} vs. R_{BE}
(Black Package)**



**Fig. 12 Normalized t_{on} vs. R_{BE}
(White Package)**

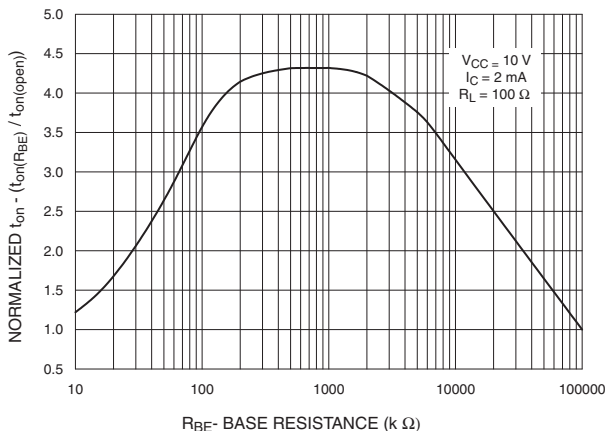


Fig. 13 Normalized t_{off} vs. R_{BE}
(Black Package)

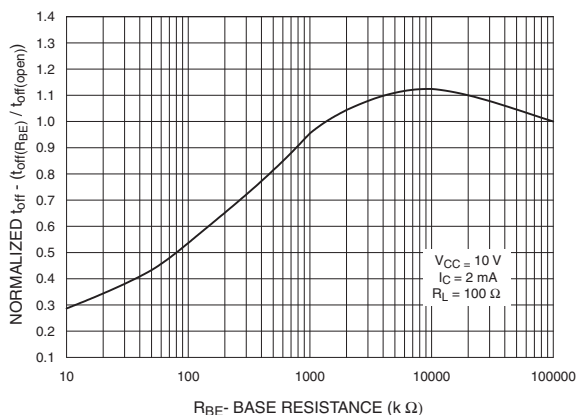


Fig. 14 Normalized t_{off} vs. R_{BE}
(White Package)

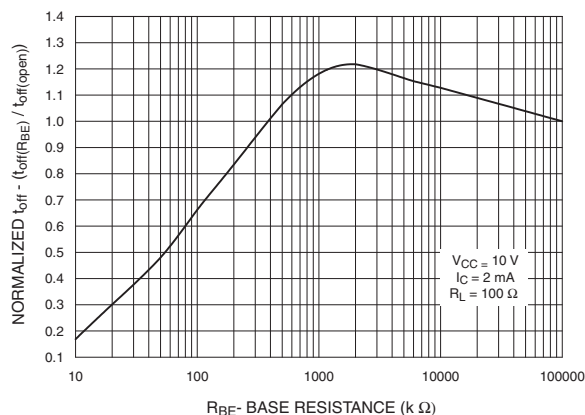


Fig. 15 LED Forward Voltage vs. Forward Current
(Black Package)

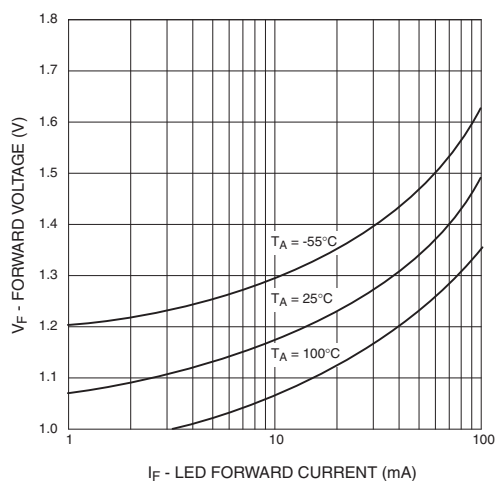


Fig. 16 LED Forward Voltage vs. Forward Current
(White Package)

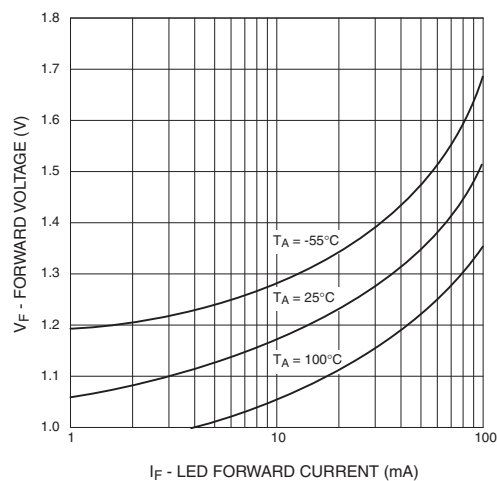


Fig. 17 Collector-Emitter Saturation Voltage vs Collector Current
(Black Package)

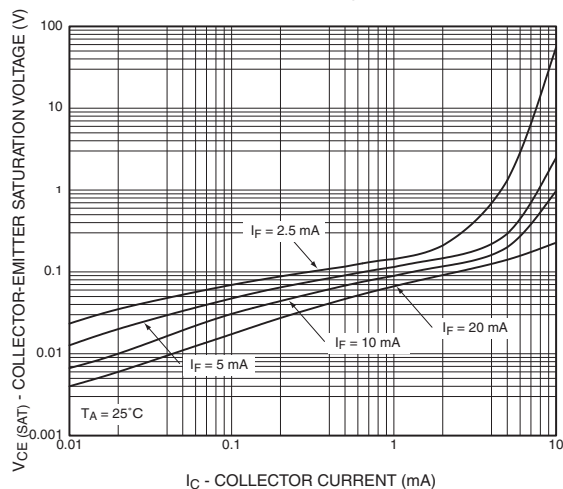
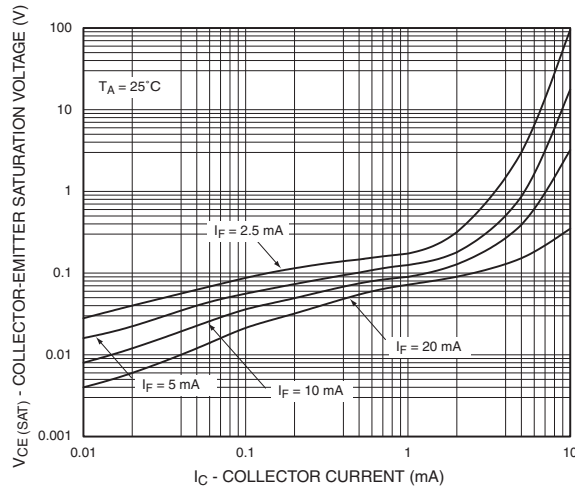


Fig. 18 Collector-Emitter Saturation Voltage vs Collector Current
(White Package)



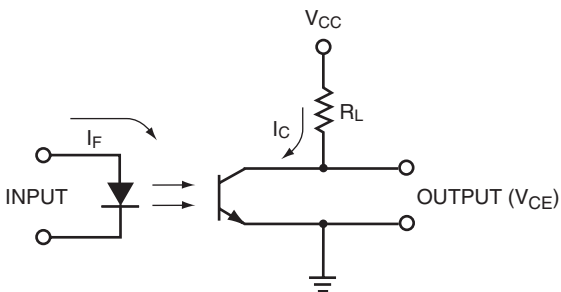
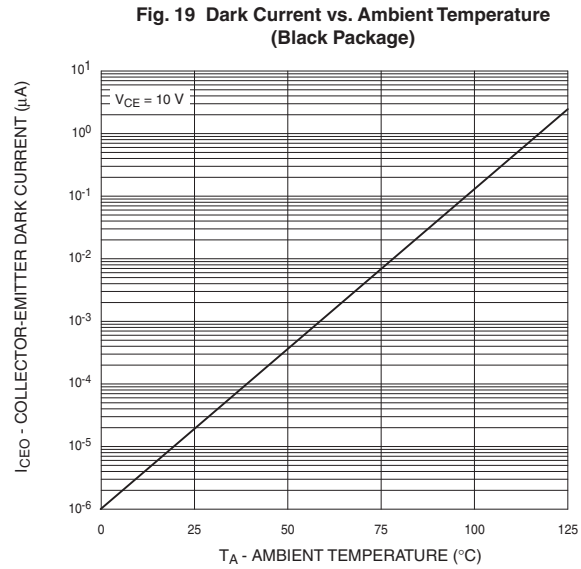


Figure 20. Switching Time Test Circuit

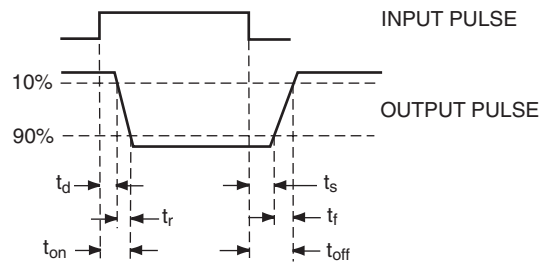
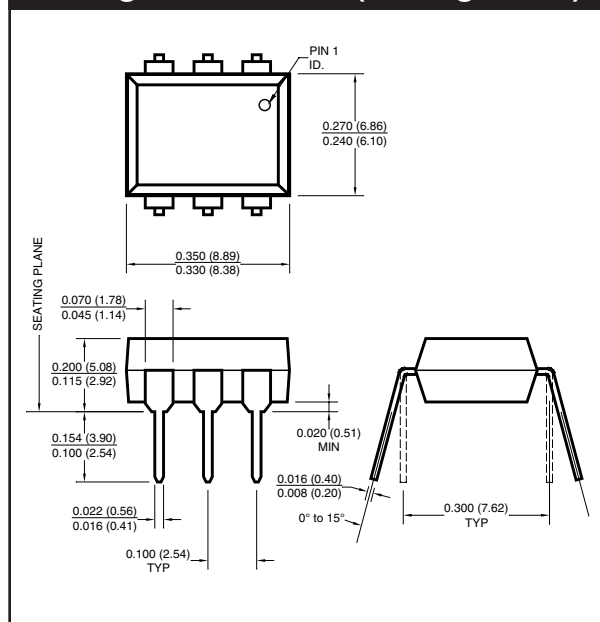


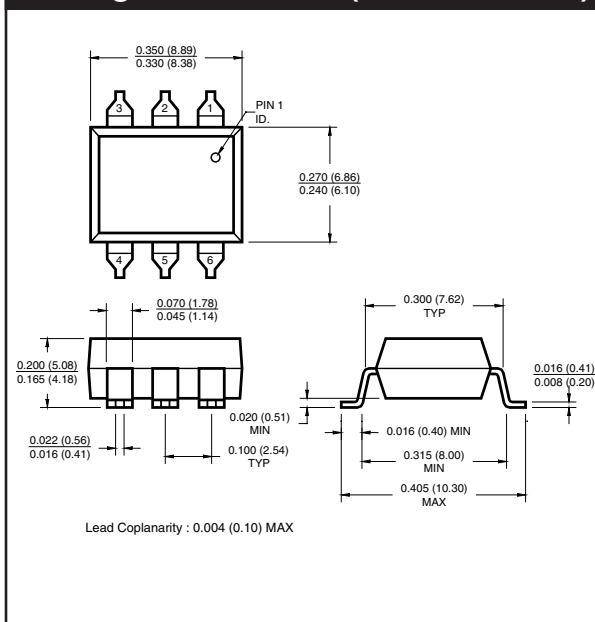
Figure 21. Switching Time Test Circuit

Black Package (No -M Suffix)

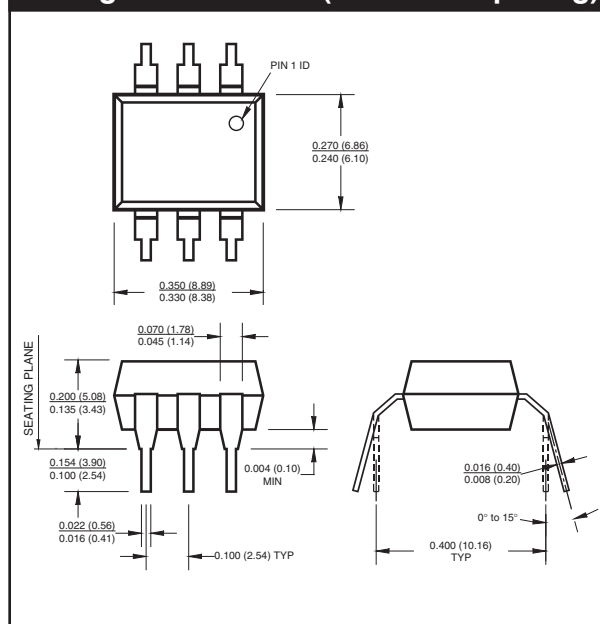
Package Dimensions (Through Hole)



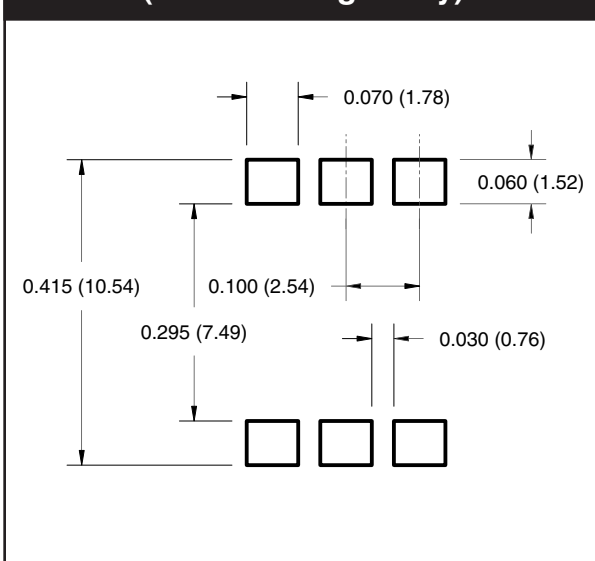
Package Dimensions (Surface Mount)



Package Dimensions (0.4" Lead Spacing)



Recommended Pad Layout for Surface Mount Leadform (Black Package Only)

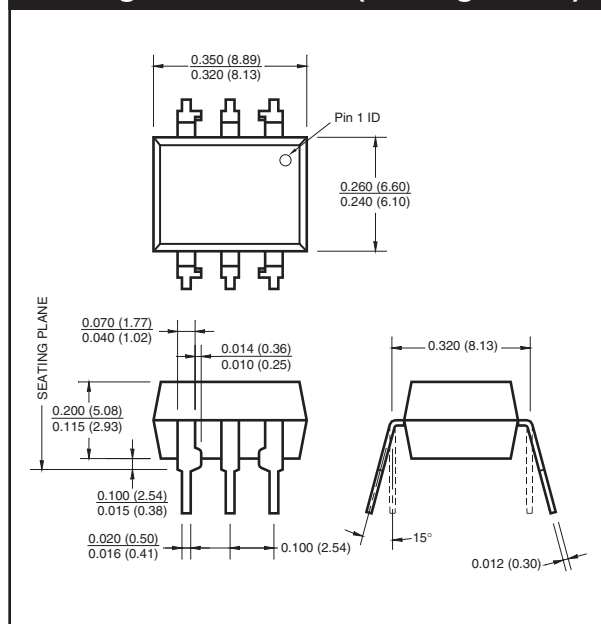


NOTE

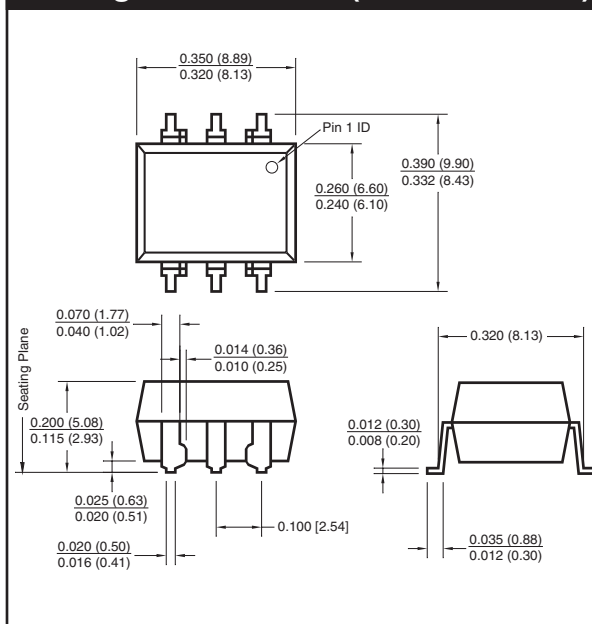
All dimensions are in inches (millimeters)

White Package (-M Suffix)

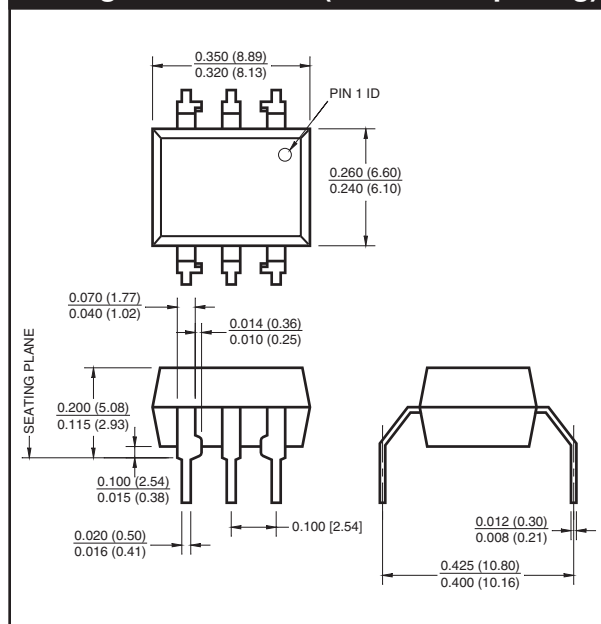
Package Dimensions (Through Hole)



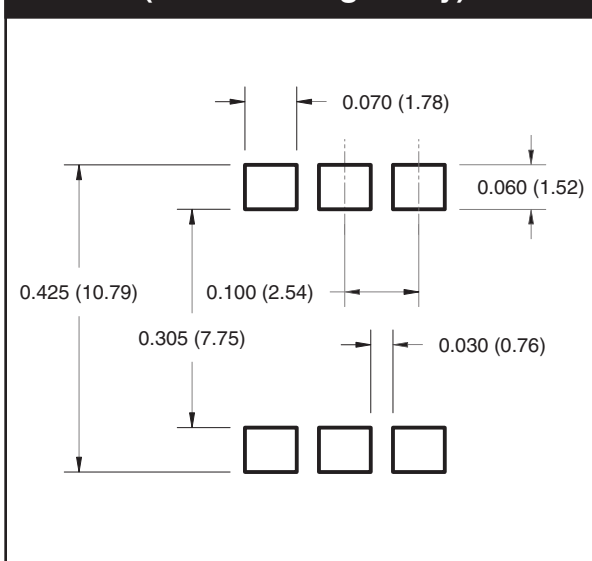
Package Dimensions (Surface Mount)



Package Dimensions (0.4" Lead Spacing)



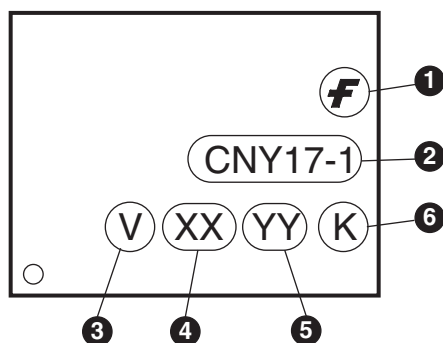
Recommended Pad Layout for Surface Mount Leadform (White Package Only)



NOTE

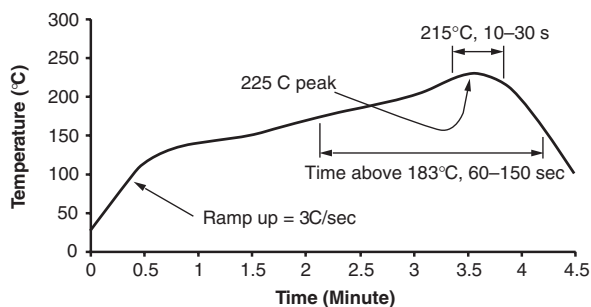
All dimensions are in inches (millimeters)

Marking Information (Black package non 'M' suffix)



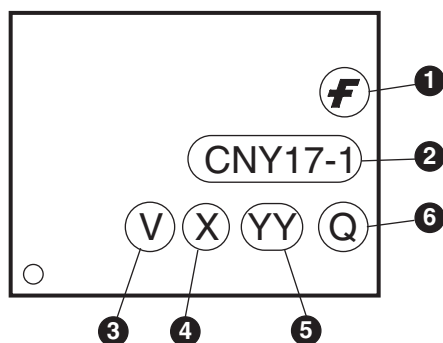
Definitions	
1	Fairchild logo
2	Device number
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)
4	Two digits year code, e.g., '03'; One digit year code for 'M' version, e.g. '5'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

Reflow Profile (Black Package, No Suffix)



- Peak reflow temperature: 225°C (package surface temperature)
- Time of temperature higher than 183°C for 60–150 seconds
- One time soldering reflow is recommended

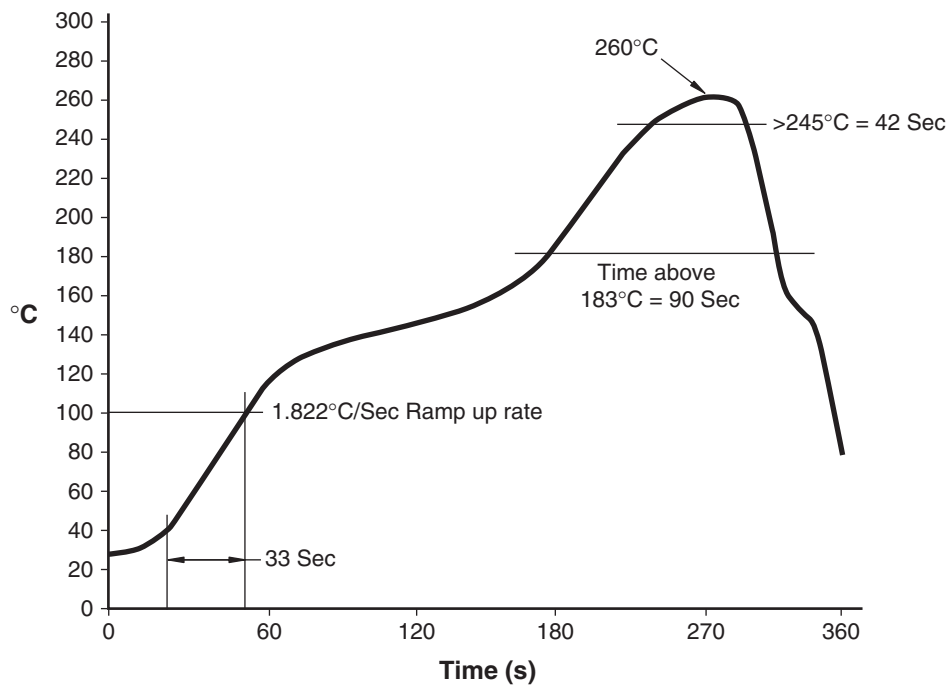
Marking Information (White package M suffix)



Definitions

1	Fairchild logo
2	Device number
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)
4	Single digit year code, e.g. '5'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

Reflow Profile (White Package, M Suffix)



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Bottomless [™]	FPS [™]	MICROCOUPLER [™]	QFET [®]	TinyLogic [®]
Build it Now [™]	FRFET [™]	MicroFET [™]	QS [™]	TINYOPTO [™]
CoolFET [™]	GlobalOptoisolator [™]	MicroPak [™]	QT Optoelectronics [™]	TruTranslation [™]
CROSSVOLT [™]	GTO [™]	MICROWIRE [™]	Quiet Series [™]	UHC [™]
DOMET [™]	HiSeC [™]	MSX [™]	RapidConfigure [™]	UltraFET [®]
EcoSPARK [™]	I ² C [™]	MSXPro [™]	RapidConnect [™]	UniFET [™]
E ² CMOS [™]	i-Lo [™]	OCX [™]	μSerDes [™]	VCX [™]
EnSigna [™]	ImpliedDisconnect [™]	OCXPro [™]	SILENT SWITCHER [®]	Wire [™]
FACT [™]	IntelliMAX [™]	OPTOLOGIC [®]	SMART START [™]	
FACT Quiet Series [™]		OPTOPLANAR [™]	SPM [™]	
Across the board. Around the world. [™]		PACMAN [™]	Stealth [™]	
The Power Franchise [®]		POP [™]	SuperFET [™]	
Programmable Active Droop [™]		Power247 [™]	SuperSOT [™] -3	
		PowerEdge [™]	SuperSOT [™] -6	

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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
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